

**Notice of References Cited**

Application/Control No.

10/644,143

Applicant(s)/Patent Under  
Reexamination  
SANCHEZ ET AL.

Examiner

Frederick F. Krass

Art Unit

1614

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,184,219	02-2001	Evenden et al.	514/217
	B	US-6,169,105	01-2001	Wong et al.	514/415
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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